THE TME SOLUTION

Non-Destructive Blister Card Test System from the Specialists



Non-destructive testing of non-porous blister cards

Customized test chambers accommodate your particular process needs, blister card sizes and shapes to detect holes as small as 5 microns.

Interchangeable test chambers enable you to test a variety of blister card sizes and shapes using the same basic fixture.

Gross Leak Detector to detect open or broken seals built into the leak test.



The Ultimate in Flexibility:

- Highly Repeatable
- Quantitative Results
- Pressure or Vacuum Decay Testing
- Detects Leaks from Pinholes, Cracks,
 Seal and Channel Leaks
- Statistics Mode for Process Control
- Medical, Nutriceutical and Pharmaceutical Applications
- NIST Traceable Calibration Services
- CFR Part 11 Data Protection

The TME Solution-C Blister Card Test System produces quantitative results in pharmaceutical, nutriceutical or food bottles by combining the sensitivity of pressure decay leak testing with the simplicity of sealed fixtures. This highly sensitive method uses a proprietary chamber design to find leaks in a variety of blister card sizes and shapes.

TMElectronics, Inc.

Specialists in Leak, Flow and Package Testing

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TME Solution Features

- MULTIPLE STORED PROGRAMS: Program and store up to 100 different tests or test parameters
- STORES 5000 TEST RESULTS
- ADJUST SET-UP TIMES (fill, settle, test)
- SET REJECT LIMITS to detect fine or gross leaks
- TWO WAY RS232 COMPUTER CONNECTION AVAILABLE for data collection and remote parameter control
- AUDIBLE AND VISUAL REJECT ALARM
- EASY TO USE TOUCH SCREEN MENUS

SPECIFICATIONS

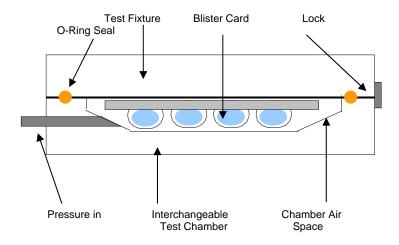
TME SOLUTION-C LEAK AND FLOW TESTER

Power	
Test Channels	Power ON/OFF Switch
Single Tests	Backlit Blue LCD, 40 character x 16
	Alphanumeric/Graphic DisplayPSI, Inches of H2O, kPa, mbar,
more DATALOG Memory Tests	
	Up to 100
	ean and Range Charts, Histograms,
Manual Output	Deviation, Averages, Min/Max, UCL & LCL Prints the Test Setup Parameters,
Automatic Output Auxiliary Output	Results, Datalog and Statistics on DemandCurrent Test Results if Printer is Connected and Ready24V PLC interface
Programs Calibration Timer Ranges MODEL PRESSURE	Two Way Up & Downloadable
100, RESOLUTION: Decay	5.0-250 psig; Vacuum 0.2-28 inHg yMaximum .0001 psi (.01

mbar/sec)

What is Pressure/Vacuum Decay Chamber Testing?

When a blister card is placed in a surrogate chamber, a pressure differential can be created across the non-porous barrier on the package seal. Once stabilized, air movement from the higher pressure to the lower will indicate the presence of a leak path, providing a quantitative measure of package integrity without disrupting the blisters' seals.



The blister card is enclosed in the test chamber and the fixture locked. The airspace in the chamber is pressurized, stabilized and tested for pressure decay. No decay, no leaks; if a leak exists in the blister card seal or material, there will be measurable pressure decay.

The chamber test can also be configured as a vacuum test for appropriate applications.

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